


<b>Search Notes</b>  	<b>Application/Control No.</b>  09592599	<b>Applicant(s)/Patent Under Reexamination</b>  WANG ET AL.
	<b>Examiner</b>  MYLINH TRAN	<b>Art Unit</b>  2179

SEARCHED			
Class	Subclass	Date	Examiner
715	733-740, 700, 764, 835, 853	6/5/09	MLT
709	203, 220, 223, 224	6/5/09	MLT
700	19, 20, 17, 83	6/5/09	MLT

SEARCH NOTES			
Search Notes		Date	Examiner
USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB and NPL		6/5/09	MLT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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